

Vishay Siliconix

RoHS

COMPLIANT

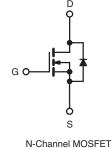


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	250				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.45			
Q _g (Max.) (nC)	41				
Q _{gs} (nC)	6.5				
Q _{gd} (nC)	22				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION			
Package	TO-220 FULLPAK		
Lead (Pb)-free	IRFI634GPbF		
Lead (FD)-nee	SiHFI634G-E3		
SnPb	IRFI634G		
	SiHFI634G		

ABSOLUTE MAXIMUM RATINGS $T_{C} = 25 \text{ °C}$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	250	v		
Gate-Source Voltage			V _{GS}			± 20
Continuous Drain Current	V_{GS} at 10 V $\frac{T_0}{T_0}$	T _C = 25 °C	- I _D	5.6		
		T _C = 100 °C		3.5	А	
Pulsed Drain Current ^a			I _{DM}	22		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	300	mJ	
Repetitive Avalanche Current ^a		I _{AR}	I _{AR} 5.6			
Repetitive Avalanche Energy ^a			E _{AR}	E _{AR} 3.5		
Maximum Power Dissipation	T _C =	25 °C	P _D 35		W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
			-	1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 15 mH, R_G = 25 Ω , I_{AS} = 5.6 A (see fig. 12).

c. $I_{SD} \leq 5.6$ A, $dI/dt \leq 120$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 150 \ ^{\circ}C.$

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	ТҮР		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 65						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6				°C/W		
	uplace other	vice noted						
SPECIFICATIONS $T_J = 25 \text{ °C}$, PARAMETER	SYMBOL	1	T CONDITI		MIN.	TYP.	MAX.	UNIT
Static	STMBOL	TES	CONDITI	0113	WIIN.	116.	WAA.	UNIT
Drain-Source Breakdown Voltage	V _{DS}	V	= 0 V, I _D = 2	50	250			V
V _{DS} Temperature Coefficient	v _{DS} ∆V _{DS} /TJ		$rac{1}{10} = 0$, $r_{\rm D} = 2$ e to 25 °C,		-	0.30	-	V/°C
						0.30		V
Gate-Source Threshold Voltage	V _{GS(th)}		V_{GS} , $I_D = 2$		2.0	-	4.0	-
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		250 V, V _{GS}		-	-	25	μA
	6	$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$		-	-	250	0	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	5	= 3.4 A ^b	-	-	0.45	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	3.4 A ⁵	2.5	-	-	S
Dynamic	-	1						1
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	770	-	рF	
Output Capacitance	Coss			-	190	-		
Reverse Transfer Capacitance	C _{rss}			-	52	-		
Drain to Sink Capacitance	С		f = 1.0 MHz	<u>.</u>	-	12	-	
Total Gate Charge	Qg				-	-	41	
Gate-Source Charge	Q_gs	$V_{GS} = 10 V$.6 A, V _{DS} = 200 V, e fig. 6 and 13 ^b	-	-	6.5	nC
Gate-Drain Charge	Q _{gd}				-	-	22	
Turn-On Delay Time	t _{d(on)}				-	9.6	-	
Rise Time	t _r		125 V, I _D =		-	21	-	
Turn-Off Delay Time	t _{d(off)}	R _G = 12 Ω, R _D = 22 Ω, see fig. 10 ^b		-	42	-	ns	
Fall Time	t _f				-	19	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	L _S			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.6	A	
Pulsed Diode Forward Currenta	I _{SM}			-	-	22		
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 5.6 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.0	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dl/dt = 100 A/μs ^b		-	220	440	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.2	2.4	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_C					_D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

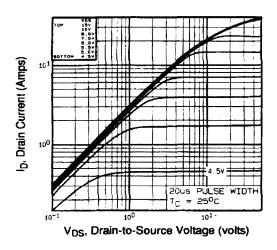


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

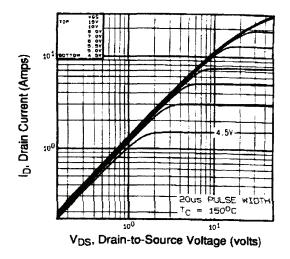


Fig. 2 - Typical Output Characteristics, T_C = 150 $^\circ C$

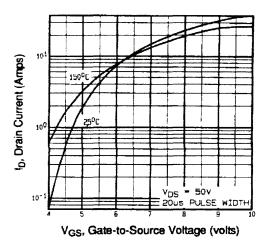


Fig. 3 - Typical Transfer Characteristics

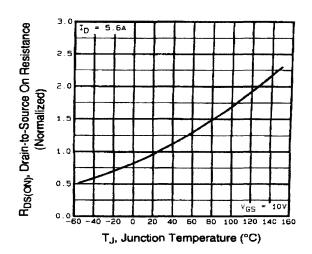


Fig. 4 - Normalized On-Resistance vs. Temperature

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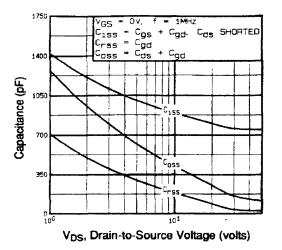


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

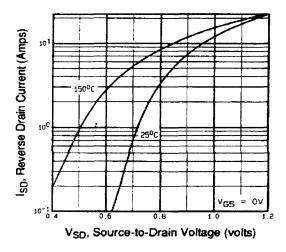


Fig. 7 - Typical Source-Drain Diode Forward Voltage

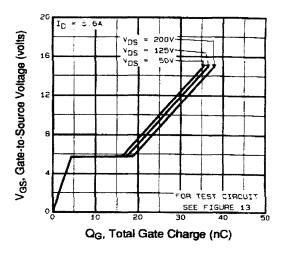


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

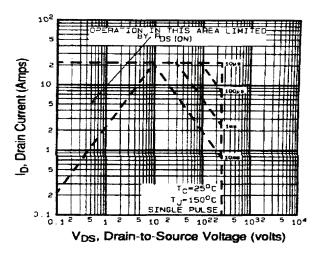


Fig. 8 - Maximum Safe Operating Area



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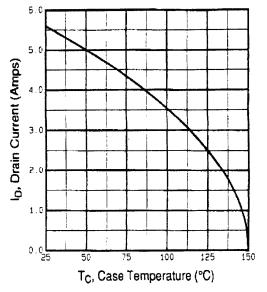


Fig. 9 - Maximum Drain Current vs. Case Temperature

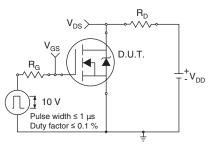


Fig. 10a - Switching Time Test Circuit

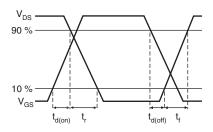
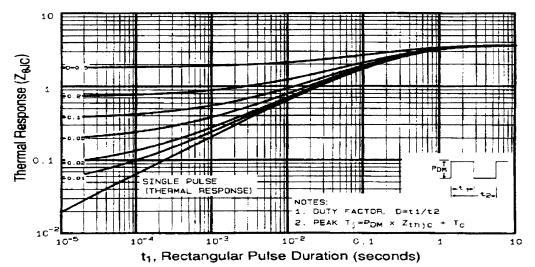


Fig. 10b - Switching Time Waveforms





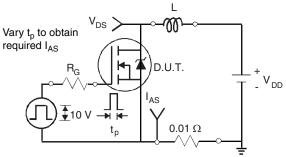


Fig. 12a - Unclamped Inductive Test Circuit

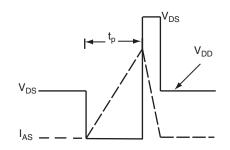


Fig. 12b - Unclamped Inductive Waveforms

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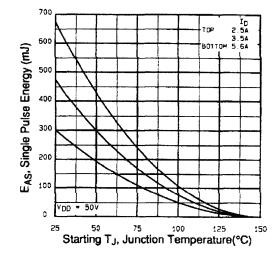


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

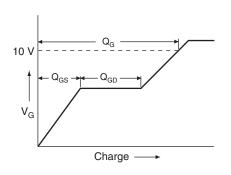
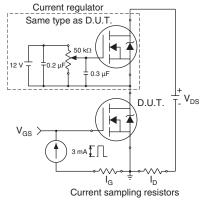


Fig. 13a - Basic Gate Charge Waveform

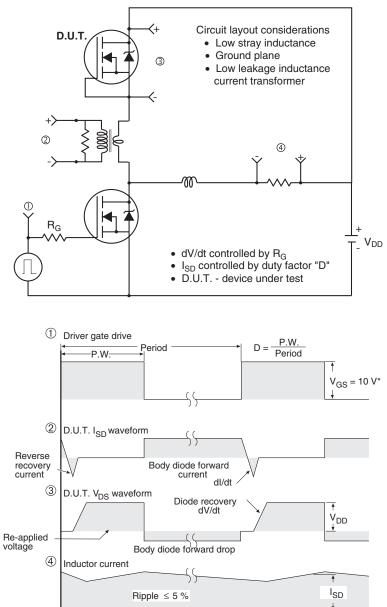






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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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